



National Institute of Standards & Technology

Certificate of Analysis

Standard Reference Material[®] 854a

Aluminum Alloy 5182

(In Cooperation with ASTM International)

This Standard Reference Material (SRM) is intended primarily for use in evaluating chemical and instrumental methods of analysis. A unit of SRM 854a consists of a bottle containing approximately 40 g of fine millings. Aluminum Alloy 5182 is also available in disk form as SRM 1241c.

The certified values for 10 elements in SRM 854a are listed in Table 1. A reference value for one element is listed in Table 2. Information values for two elements are listed in Table 3. For all elements, values are reported as mass fractions [1]. Value assignment categories are based on the definition of terms and modes used at NIST for chemical reference materials [2].

Certified Values: A NIST certified value is a value for which NIST has the highest confidence in its accuracy, in that all known or suspected sources of bias have been investigated or accounted for by NIST. A certified value is the present best estimate of the true value based on the results of analyses performed at NIST and collaborating laboratories using the test methods listed in Table 4. The uncertainty listed with the value is an expanded uncertainty based on a 95 % confidence interval [3] and is calculated according to the method in the ISO and NIST Guides [4].

Reference Value: Reference values are non-certified values that are the present best estimates of the true values. However, the values do not meet the NIST criteria for certification and are provided with associated uncertainties that may not include all sources of uncertainty. The uncertainty listed with the value is an expanded uncertainty based on a 95 % confidence interval [3] and is calculated according to the method in the ISO and NIST Guides [4].

Information Values: An information value is considered to be a value that will be of interest to the SRM user, but insufficient information is available to assess the uncertainty associated with the value.

Expiration of Certification: The certification of this SRM is valid indefinitely, within the uncertainty specified, provided the SRM is handled and stored in accordance with the instructions given in this certificate (see "Instructions for Use"). However, the certification will be nullified if the SRM is damaged or contaminated.

Stability: This material is considered to be stable during the period of certification. NIST will monitor this material and will report any significant changes in certification to the purchaser. Registration (see attached sheet) will facilitate notification.

The coordination of the technical measurements for certification of this SRM was under the direction of J.R. Sieber of the NIST Analytical Chemistry Division.

Analytical measurements for certification of this SRM were performed by M.R. Winchester of the NIST Analytical Chemistry Division.

Statistical consultation for this SRM was provided by D.D. Leber of the NIST Statistical Engineering Division.

Stephen A. Wise, Chief
Analytical Chemistry Division

Gaithersburg, MD 20899
Certificate Issue Date: 04 April 2006

Robert L. Watters, Jr., Chief
Measurement Services Division

The support aspects involved in the issuance of this SRM were coordinated through the NIST Measurement Services Division.

INSTRUCTIONS FOR USE

To relate analytical determinations to the certified values on this Certificate of Analysis, a minimum sample quantity of 200 mg is recommended. The millings do not require preparation prior to weighing and dissolution. The material should be stored in its original container in a cool, dry location.

Table 1. Certified Values for SRM 854a Aluminum Alloy 5182

Constituent	Value (mass fraction) (%)	Expanded Uncertainty ^(a) (mass fraction) (%)	Coverage Factor (<i>k</i>)
Si	0.1553	0.0028	2.4
Fe	0.1990	0.0049	4.3
Cu	0.0494	0.0013	2.1
Mn	0.3753	0.0057	2.0
Mg	4.474	0.070	2.0
Ni	0.0195	0.0007	2.6
Zn	0.0505	0.0009	4.3
Ti	0.0335	0.0011	2.0
V	0.0174	0.0005	2.0
Cr	0.0340	0.0010	4.3

^(a) The assigned value is an unweighted mean of the results from two analytical methods across three laboratories. The uncertainty listed with the value is an expanded uncertainty about the mean, with coverage factor *k*, calculated by combining a between-method variance with a pooled, within-method variance following the ISO and NIST Guides [4,5].

Table 2. Reference Value for SRM 854a Aluminum Alloy 5182

Constituent	Value (mass fraction) (%)	Expanded Uncertainty ^(a) (mass fraction) (%)	Coverage Factor (<i>k</i>)
Ga	0.0185	0.0009	2.4

^(a) The assigned value is an unweighted mean of the results from two analytical methods across three laboratories. The uncertainty listed with the value is an expanded uncertainty about the mean, with coverage factor *k*, calculated by combining a between-method variance with a pooled, within-method variance following the ISO and NIST Guides [4,5].

Table 3. Information Values for SRM 854a Aluminum Alloy 5182

Constituent	Value mass fraction (%)
Cd	0.0006
Sr	0.0002

Cooperating Laboratories: Analytical determinations for certification of this SRM were performed by the following laboratories:

Alcan International Limited, Arvida Research and Development Centre (Jonquière, Québec, Canada); H. Hamouche. Aluminum Company of America, Alcoa Technical Center, Alcoa Center (Pennsylvania, USA); M. Ruschak.

Material Preparation: The material for SRM 854a was obtained in the form of a single casting prepared by the Aluminum Company of America¹. Titanium was added for grain refinement of the alloy. The casting was chipped, blended and bottled at NIST under the supervision of D.F. Friend and M.P. Cronise of the Measurement Services Division.

Table 4. Analytical Methods

Element	Methods
Si	GD-OES; ICP-OES
Fe	GD-OES; ICP-OES
Cu	GD-OES; ICP-OES
Mn	GD-OES; ICP-OES
Mg	GD-OES; ICP-OES
Ni	GD-OES; ICP-OES
Zn	GD-OES; ICP-OES
Ti	GD-OES; ICP-OES
V	GD-OES; ICP-OES
Cr	GD-OES; ICP-OES
Ga	GD-OES; ICP-OES
Cd	SS-OES
Sr	GD-OES

Methods Key:

GD-OES (Glow Discharge Optical Emission Spectrometry at NIST)

ICP-OES (Inductively-Coupled Plasma Optical Emission Spectrometry at Cooperating Laboratories)

SS-OES (Spark Source Optical Emission Spectrometry at Cooperating Laboratories)

REFERENCES

- [1] Taylor, B.N.; *Guide for the Use of the International System of Units (SI)*; NIST Special Publication 811, U.S. Government Printing Office: Washington, DC (1995); available at <http://www.physics.nist.gov/Pubs>.
- [2] May, W.; Parris, R.; Beck, C.; Fassett, J.; Greenberg, R.; Guenther, F.; Kramer, G.; Wise, S.; Gills, T.; Colbert, J.; Gettings, R.; MacDonald, B.; *Definitions of Terms and Modes Used at NIST for Value-Assignment of Reference Materials for Chemical Measurements*; NIST Special Publication 260-136; U.S. Government Printing Office: Gaithersburg, MD (2000); available at http://www.cstl.nist.gov/nist839/NIST_special_publications.htm.
- [3] Hahn, G. J., and Meeker, W. Q.; *Statistical Intervals: A Guide for Practitioners*; John Wiley & Sons, Inc.: New York (1991).
- [4] ISO; *Guide to the Expression of Uncertainty in Measurement*; ISBN 92-67-10188-9, 1st ed.; International Organization for Standardization: Geneva, Switzerland (1993); see also Taylor, B.N.; Kuyatt, C.E.; *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results*; NIST Technical Note 1297; U.S. Government Printing Office: Washington, DC (1994); available at <http://physics.nist.gov/Pubs/>.
- [5] Levenson, M.S.; Banks, D.L.; Eberhardt, K.R.; Gill, L.M.; Guthrie, W.F.; Liu, H.K.; Vangel, M.G.; Yen, J.H.; Zhang, N.F.; *An Approach to Combining Results from Multiple Methods Motivated by the ISO GUM*; J. Res. Natl. Inst. Stand. Technol., Vol. 105, pp. 571–579 (2000).

Users of this SRM should ensure that the certificate in their possession is current. This can be accomplished by contacting the SRM Program at: telephone (301) 975-6776; fax (301) 926-4751; e-mail srminfo@nist.gov; or via the Internet at <http://www.nist.gov/srm>.

¹ Certain commercial equipment, instruments, or materials are identified in this certificate in order to specify adequately the experimental procedure. Such identification does not imply recommendation or endorsement by the National Institute of Standards and Technology, nor does it imply that the materials or equipment identified are necessarily the best available for the purpose.